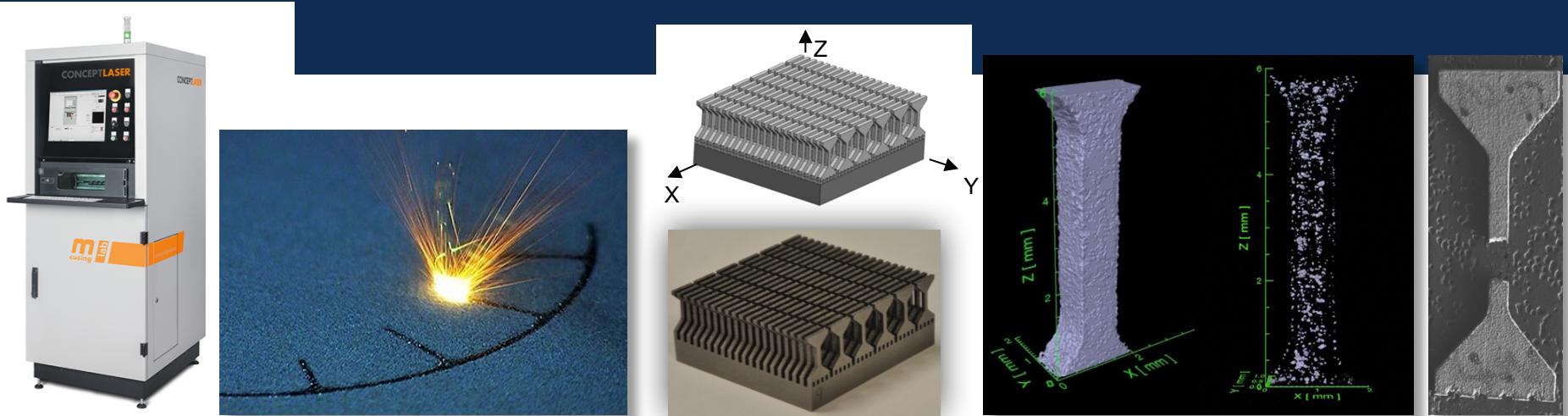


Exceptional service in the national interest



Quantifying Defect Presence in an Additively Manufactured Precipitation Hardened 17-4 Stainless Steel

**Jonathan Madison¹, Laura Swiler², Olivia Underwood¹,
Brad Boyce¹, Bradley Jared³, Jeff Rodelas⁴, Bradley Salzbrenner¹**

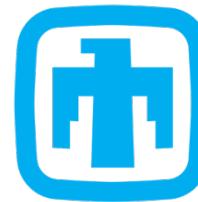
Sandia National Laboratories, Albuquerque, NM



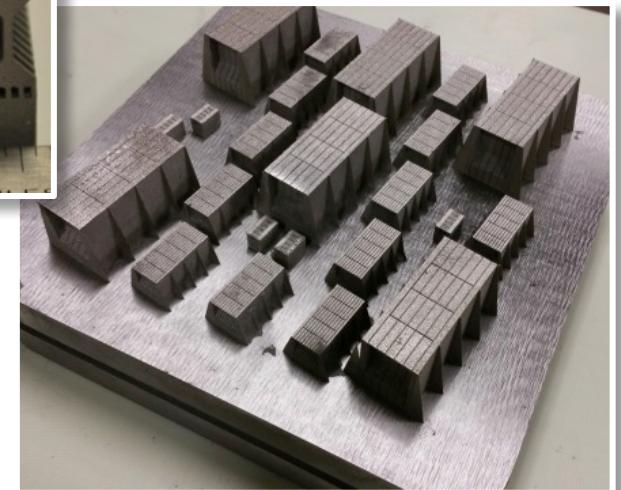
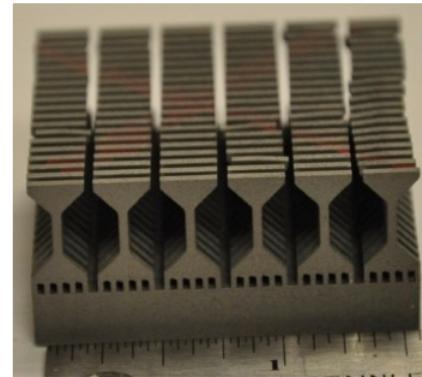
Sandia National Laboratories is a multi-program laboratory managed and operated by Sandia Corporation, a wholly owned subsidiary of Lockheed Martin Corporation, for the U.S. Department of Energy's National Nuclear Security Administration under contract DE-AC04-94AL85000. SAND NO. 2017-XXXXC

Acknowledgements

- Carl Jacques
- Joseph Romero
- Burke Kernan



**Sandia
National
Laboratories**

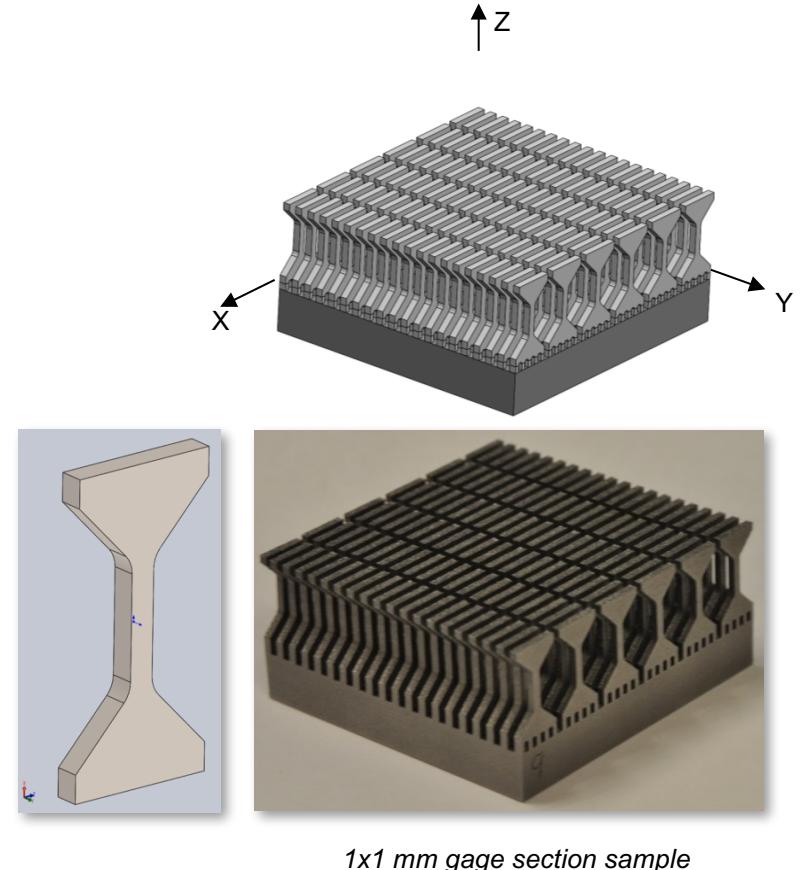


Outline

- Additive Manufacturing & Critical Defects
- High-Throughput Mechanical Testing
- Metallurgical Assessments
 - Microhardness
 - Microstructure
 - Composition
 - Surface Finish & Failure Modes
 - Fractography
- Micro-Computed Tomography
 - Defect Quantification
 - Correlations with Mechanical Response
- Conclusions

Identify *Critical* Defects

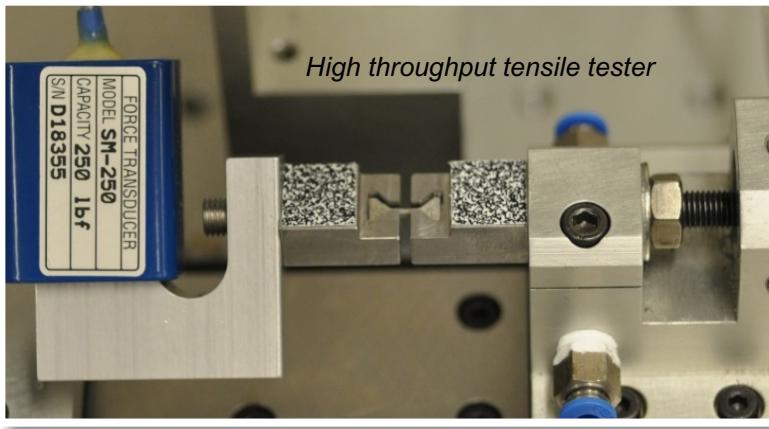
- Characterize, predict & control for laser PBF
- Quantify “signatures”
 - destructive
 - high throughput testing (HTT), fractography, metallography, serial sectioning
 - non-destructive
 - computed tomography (CT), density, process controlled resonance testing (PCRT)
 - what can we ID both accurately & efficiently?
- Understand mechanistic impacts on properties
 - characterize stochastics
 - build process-structure-property relationships to predict margins & reliability
 - **provide scientific basis for qualification of AM metals**



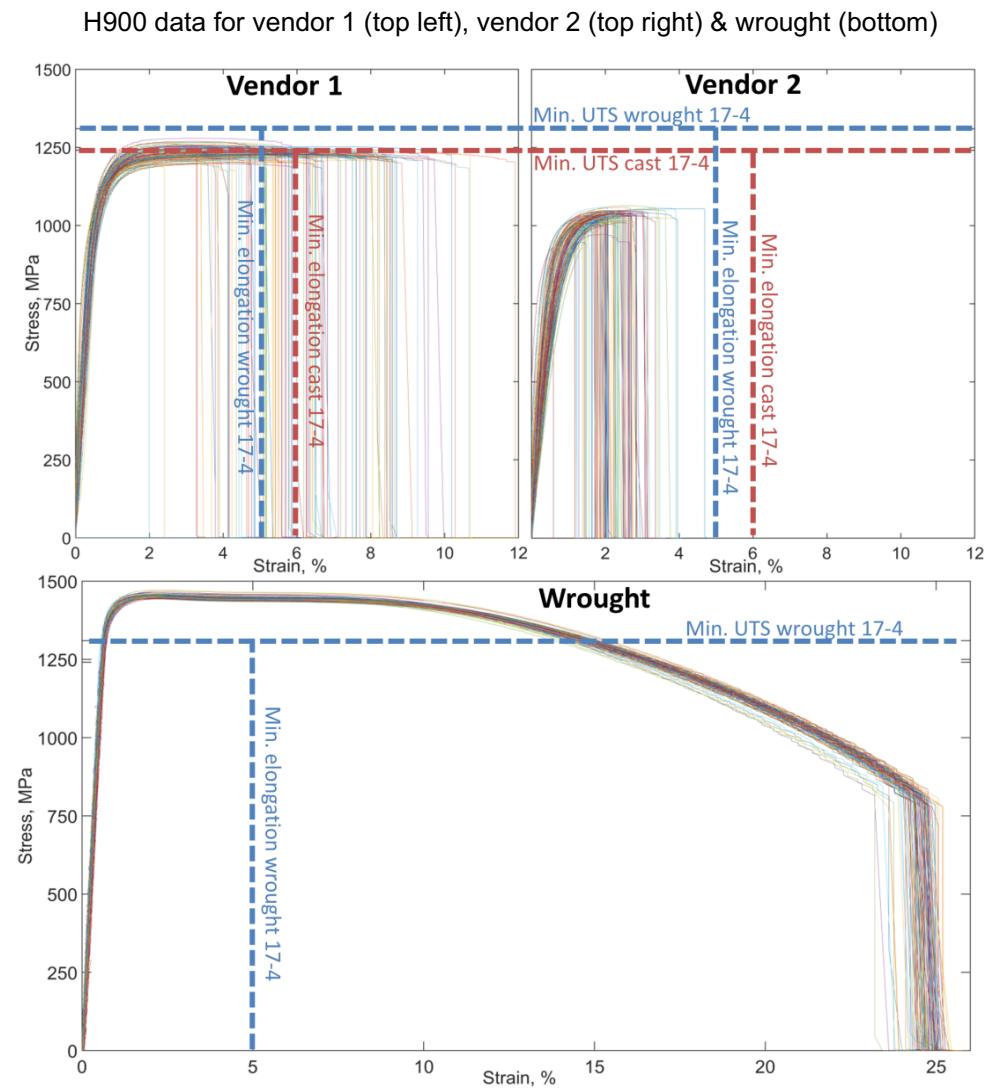
17-4 PH Stainless Steel

High-Throughput Mechanical Testing

- Quantifying mean, outliers & probabilities
 - >100 samples / test condition
 - external vendor sources
 - compared against wrought
- Defect dominated failure
 - limited area reduction
 - observed ductile dimples & shear rupture planes
 - voids & lack-of-fusion boundaries are likely crack nucleation sites



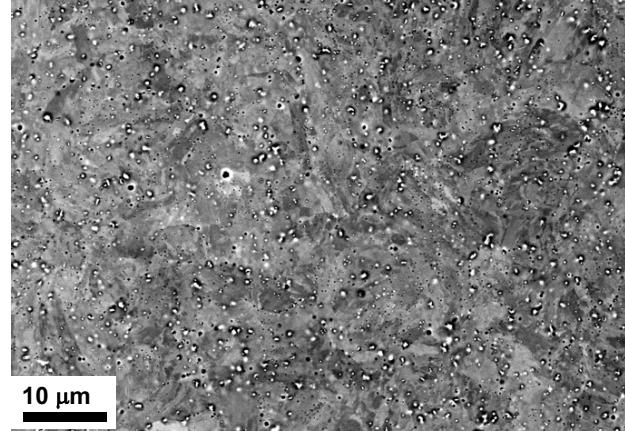
High throughput tensile tester



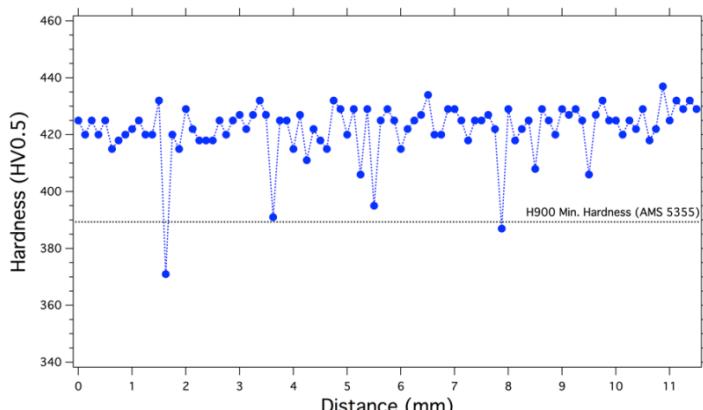
AMS spec for H900: modulus = 197 MPa, yield = 1172 MPa, UTS = 1310 MPa, strain at failure = 5%

Metallurgical Assessments

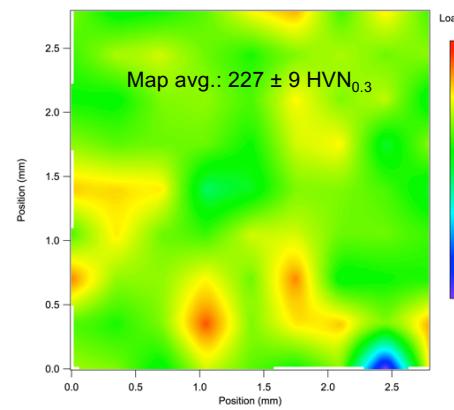
- Microhardness
- Microstructure
 - optical, SEM, EBSD, WDS microprobe
- Composition
 - LECO combustion, ICP mass-spec, XRD
 - powder analysis



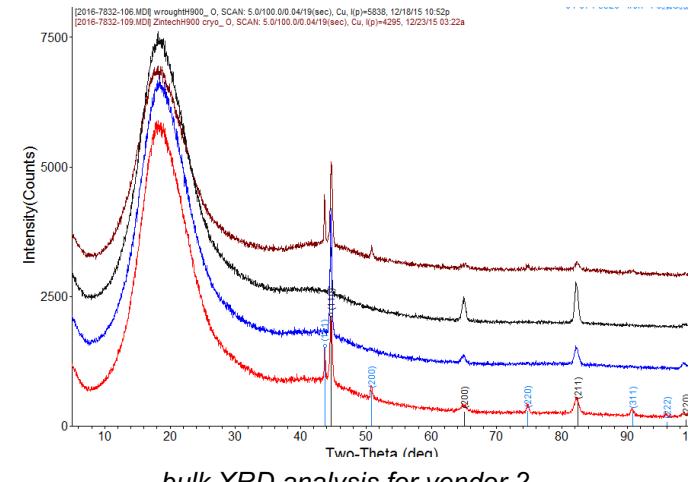
Electron backscatter channeling contrast imaging of as-printed vendor 2 17-4PH shows appreciable fraction of retained austenite



vendor 1, H900 microhardness along dogbone length

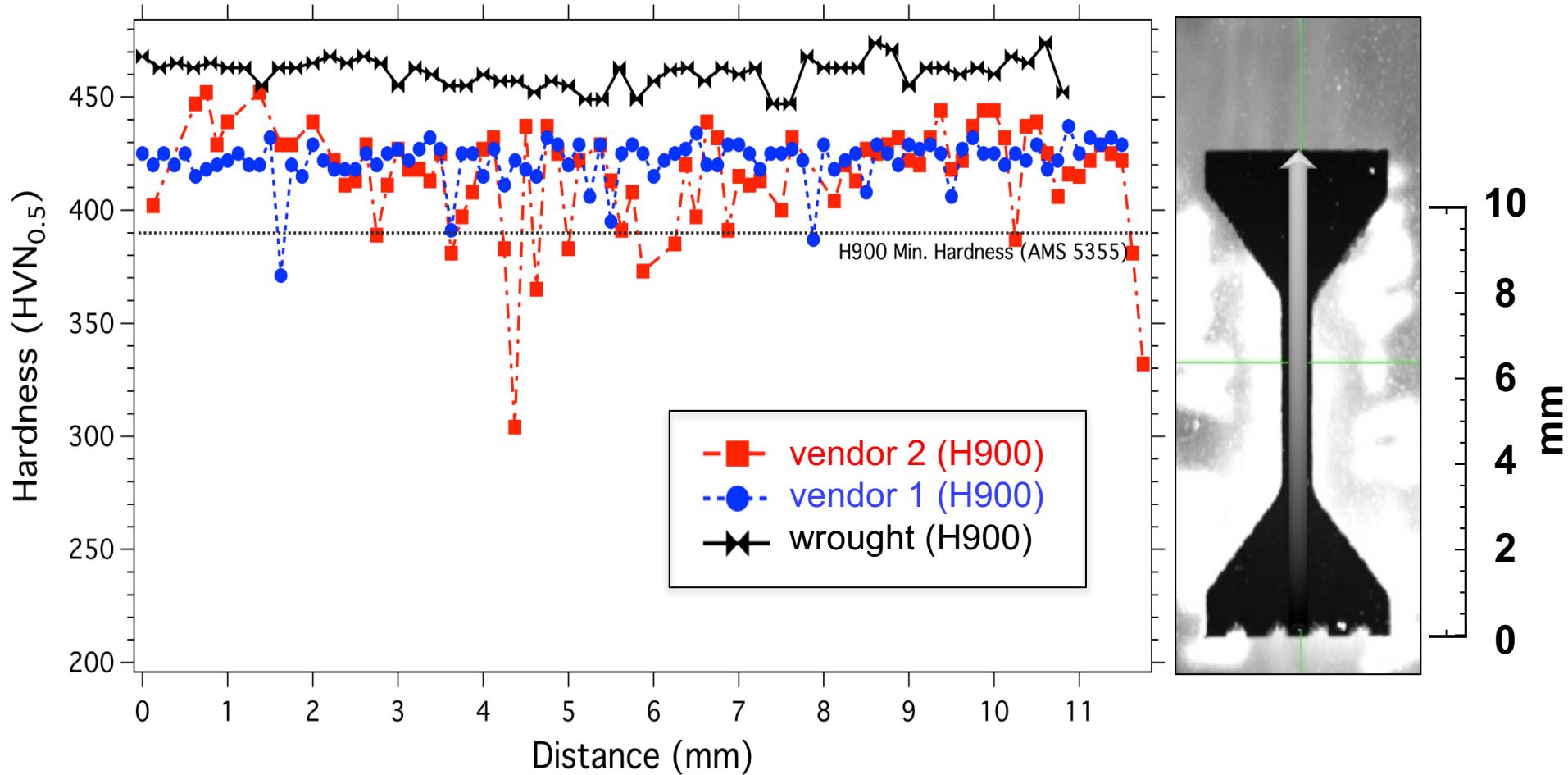


vendor 2, as-printed microhardness on gauge cross section



bulk XRD analysis for vendor 2

Microhardness

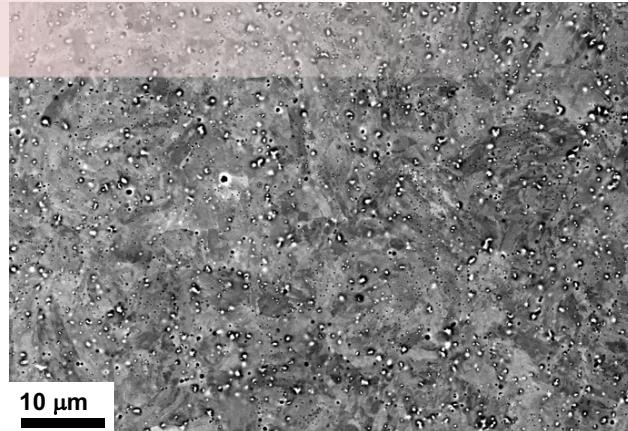


Greater variability in vendor 2 material but no intrinsic difference in hardness in comparison to vendor 1

Microstructure

Vendor 1

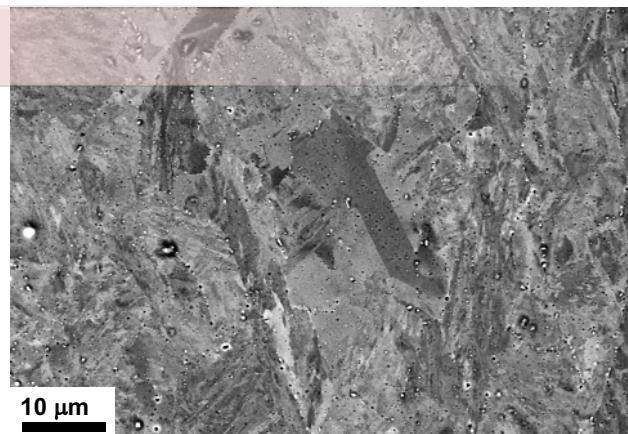
martensitic microstructure
submicron Nb-rich carbides



*SHT + H900 age
Backscatter electron micrograph*

Vendor 2

martensitic lath microstructure
submicron Nb-rich carbides



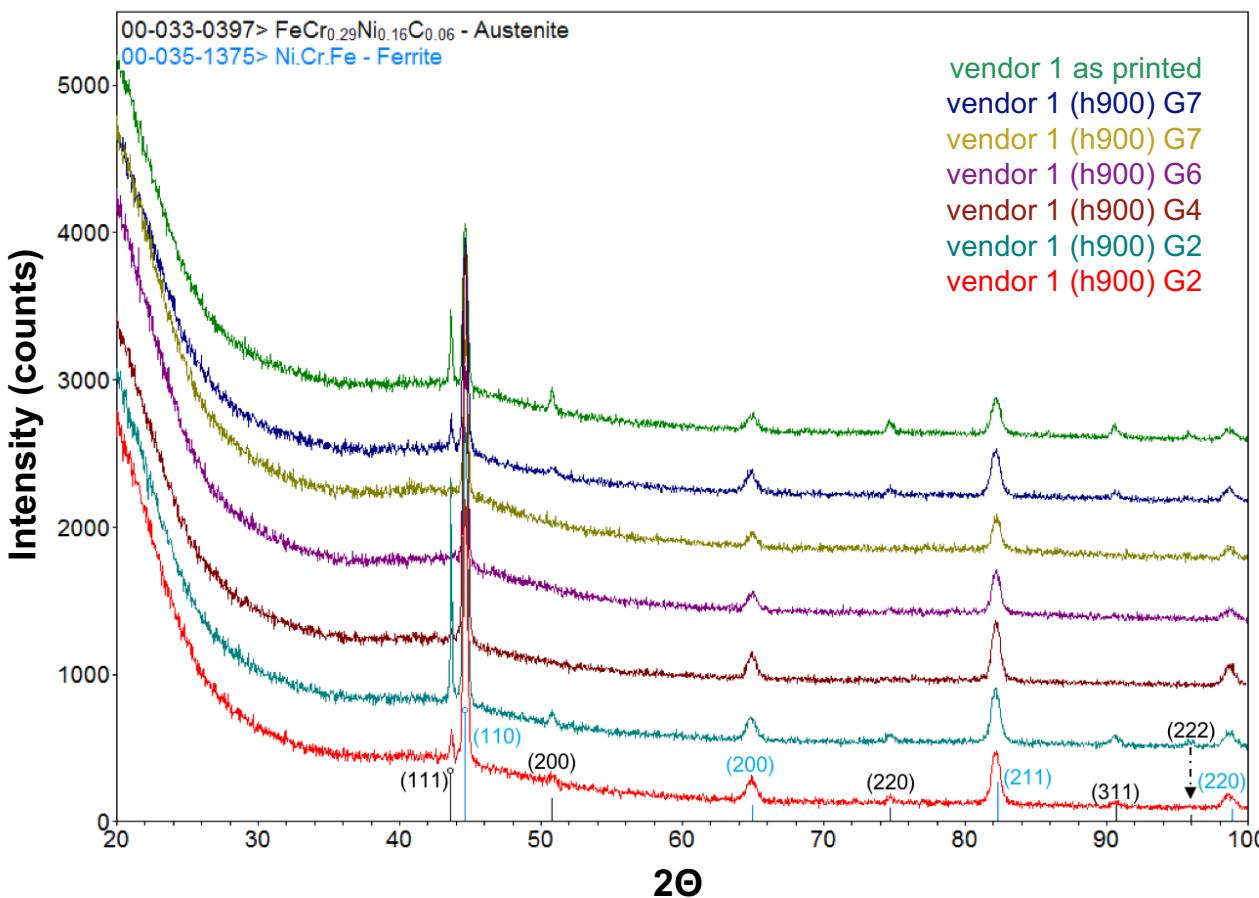
*SHT + H900 age
Backscatter electron micrograph*

Element	Vendor 1, run 2 (wt%)	Vendor 2, As Printed (wt%)
Cr	16.64	16.51
Mo	0.045	0.17
Si	0.38	0.62
Nb	0.3	0.29
V	0	0
W	0	0
Ti	0	0
Ta	0	0
Al	0	0
Ni	4.24	4.53
Mn	0.24	0.46
C	0.012	0.021
N	0.056	0.15
Co	0	0
Cu	4.05	4.08
P	0.019	0.023
S	0.003	0.006
O	0.100	0.083

bulk chemical analysis

Microstructure

Vendor 1

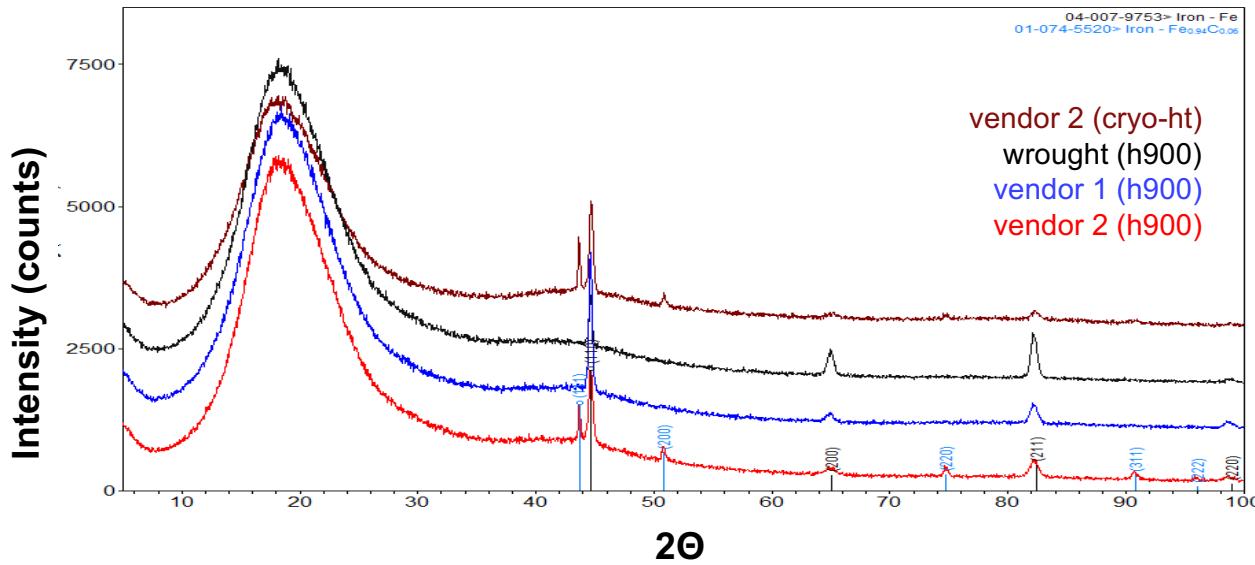


Significant amounts of retained austenite in vendor 2 material pre- and post heat treatments

Austenite largely absent in heat treated wrought and heat treated vendor 1 material

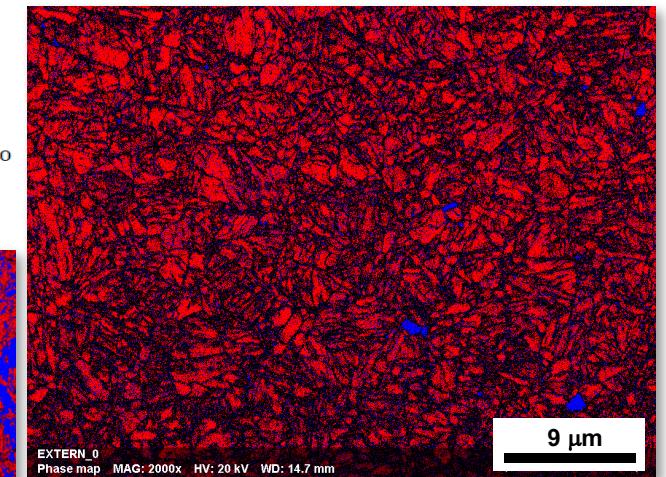
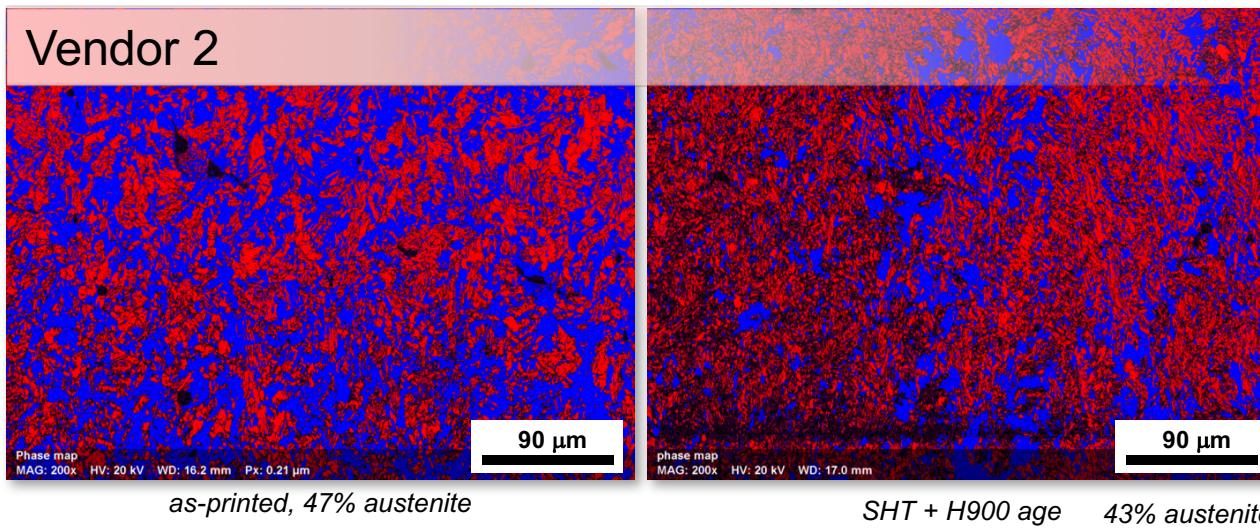
When observed in vendor 1 material, via XRD, austenite was seen to exist in the range of 12% or less

Microstructure



Significant amounts of retained austenite in vendor 2 material pre- and post heat treatments

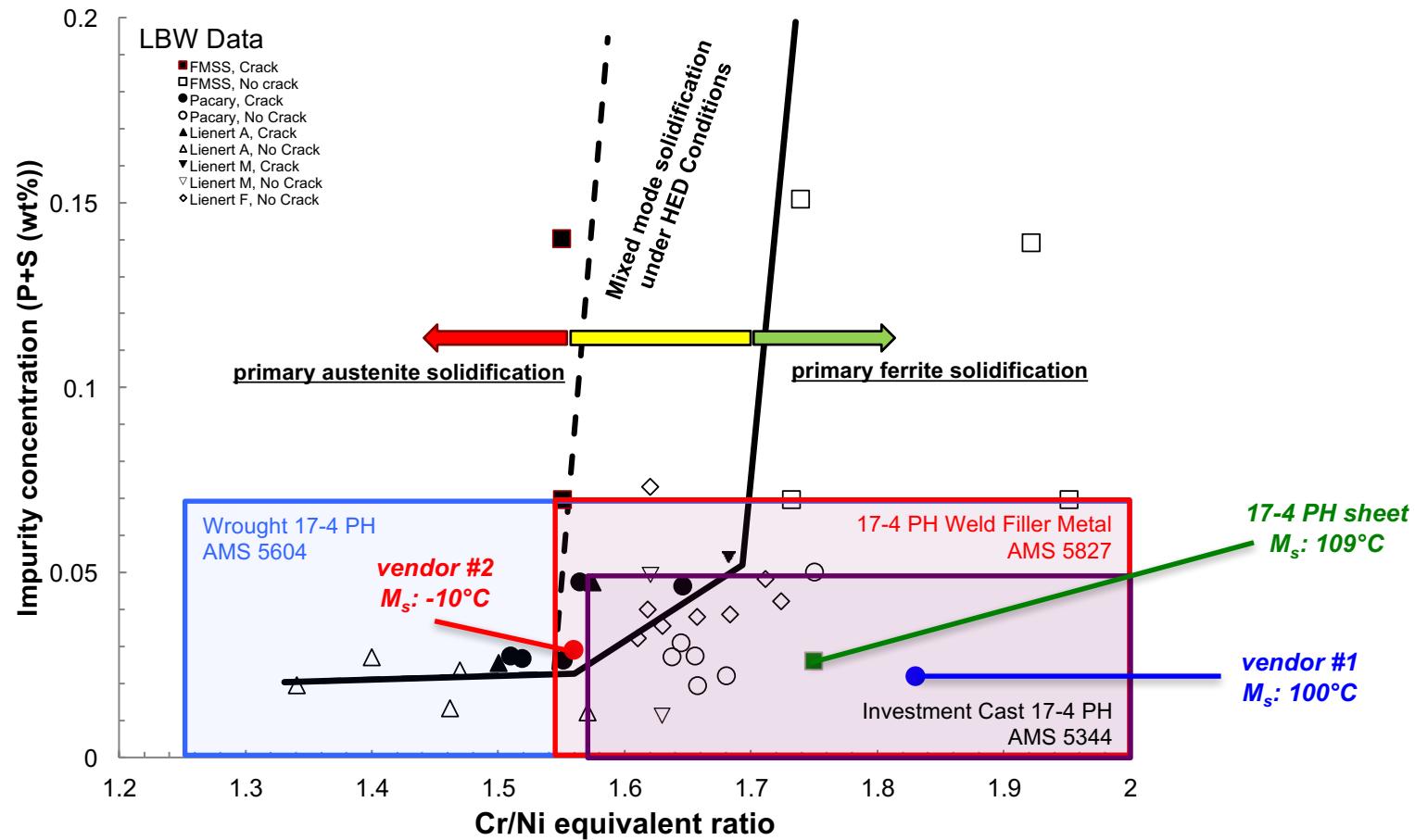
Austenite largely absent in heat treated wrought and heat treated vendor 1 material



Blue = austenite (FCC)
Red = martensite / ferrite (BCC)
Black = non-indexed

Composition

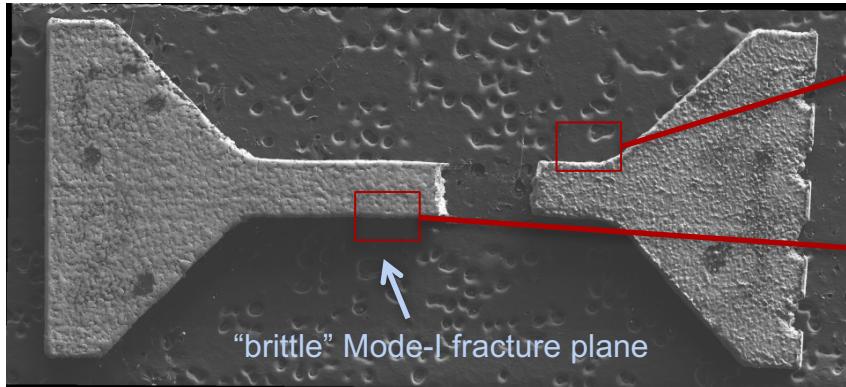
- Shows high austenite stability & propensity for primary austenite solidification



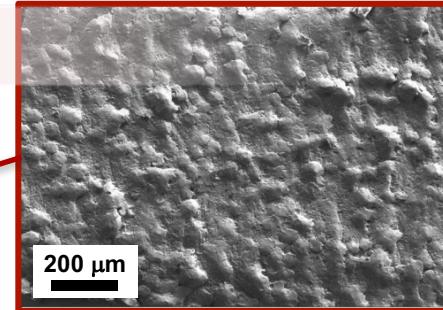
$$\text{Eichelman \& Hull: } M_s (\text{ }^\circ\text{C}) = 1302 - 42[\text{Cr}] - 61[\text{Ni}] - 33[\text{Mn}] - 28 [\text{Si}] - 1667[\text{C+N}]$$

Surface Finish & Failure Modes

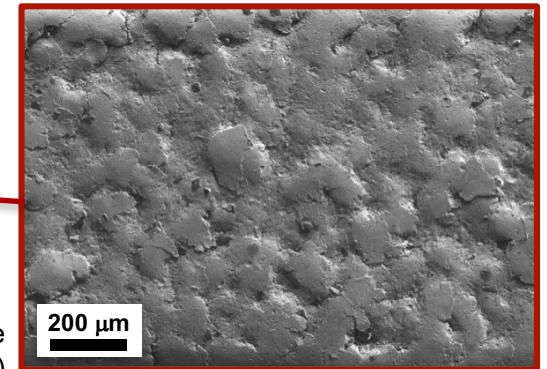
Vendor 1



Surface roughness (Ra) 5.6 mm (± 0.1 mm)
Maximum peak height (Rp) of 36 mm (± 0.6 mm)

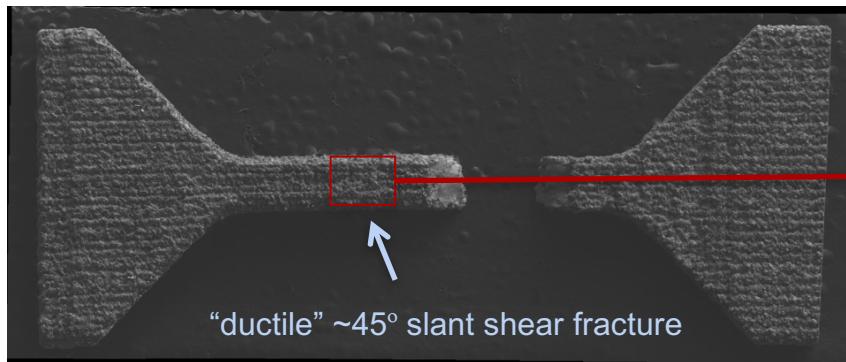


Exterior surface
(greater bead-blasting)

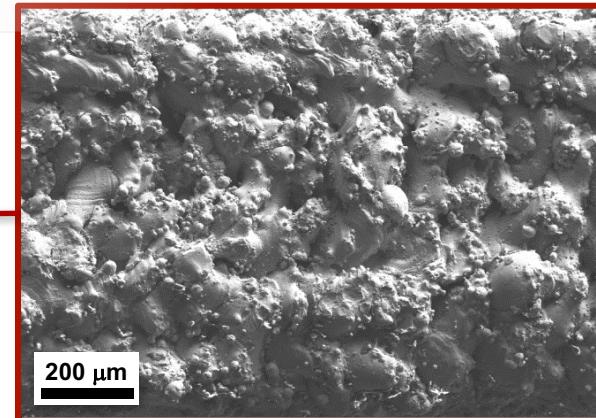


Interior surface
(lesser bead-blasting)

Vendor 2



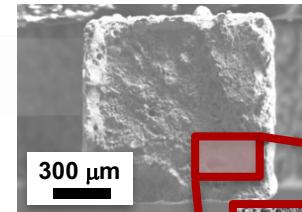
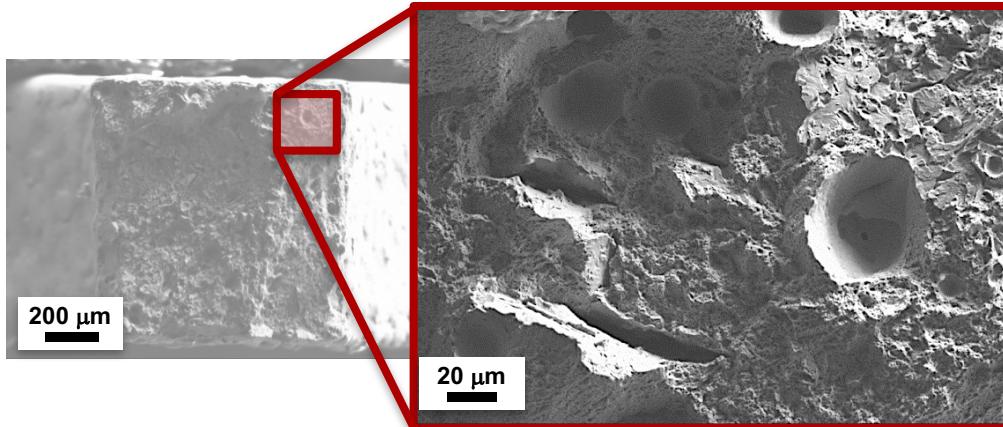
Surface roughness (Ra) 18 mm (± 0.1 mm)
Maximum peak height (Rp) of 82 mm (± 0.6 mm)



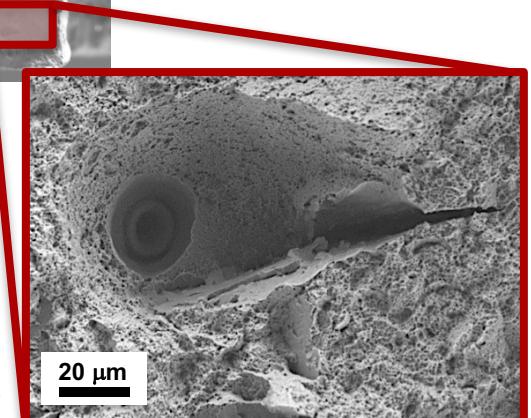
All surfaces (As printed)

Surface Finish & Failure Modes

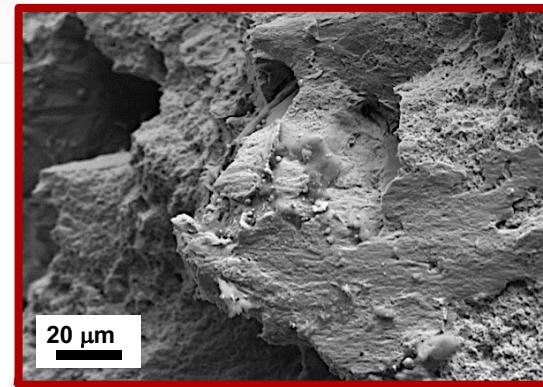
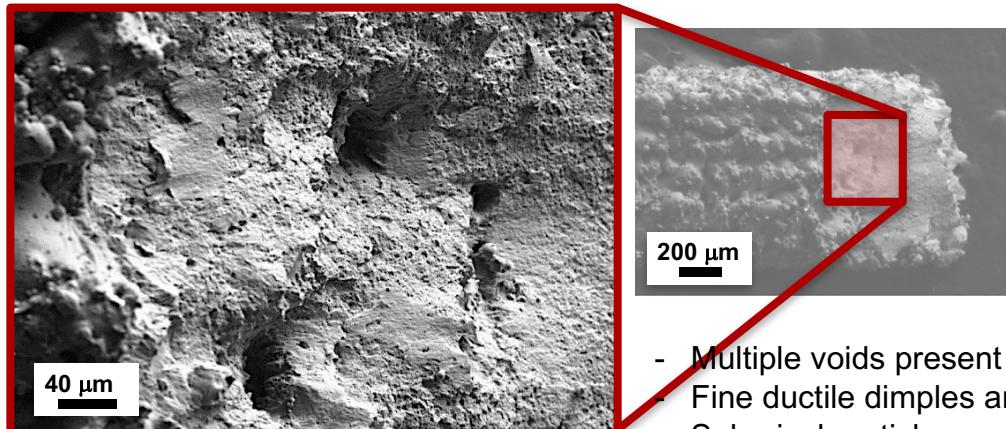
Vendor 1



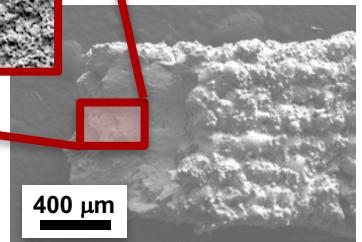
- Brittle fracture surfaces
- No clear crack initiation
- Large collections of voids and void connected cavities



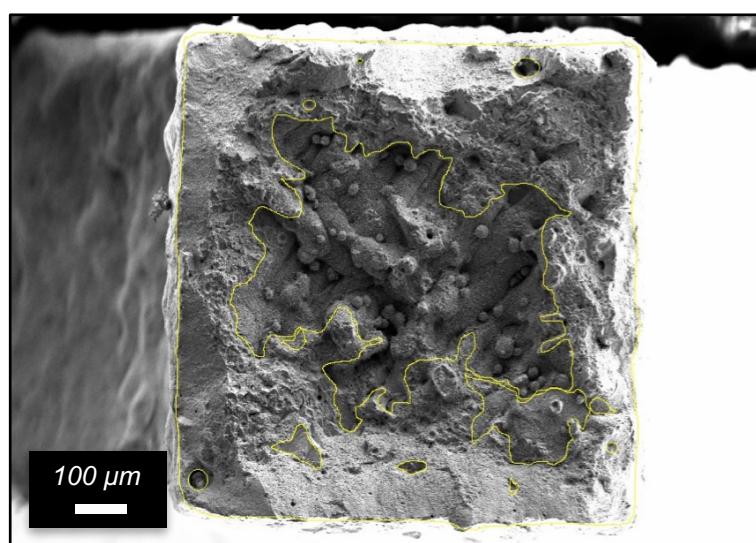
Vendor 2



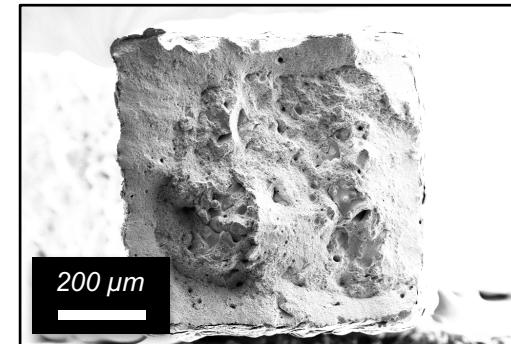
- Multiple voids present at fracture surface
- Fine ductile dimples and shear rupture planes
- Spherical particles on the fracture surface



Fractography

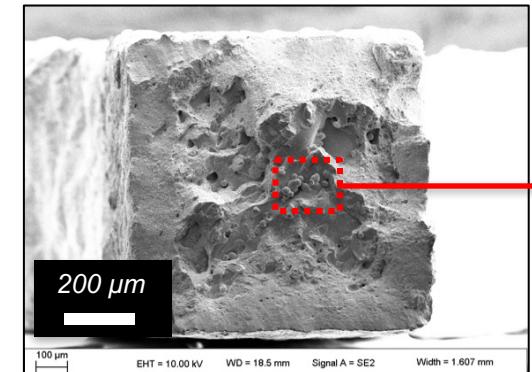


Strain-to-Failure: 10.1%

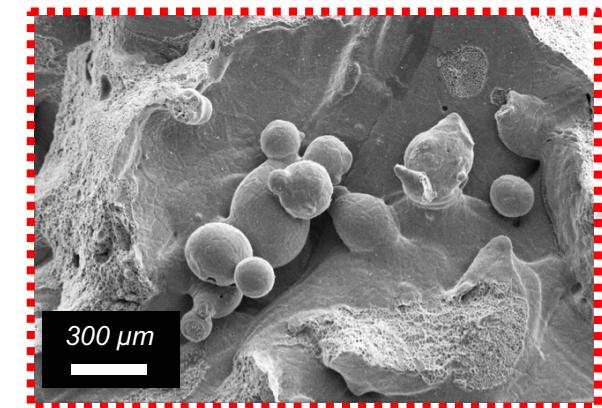
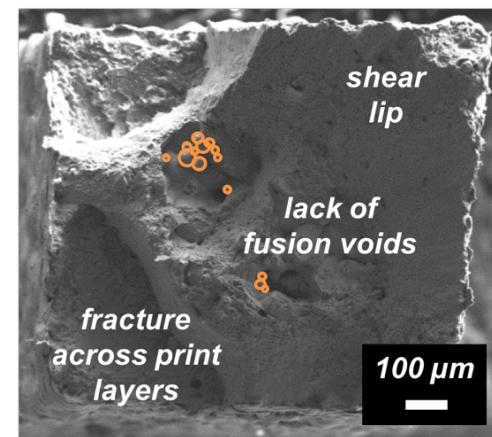
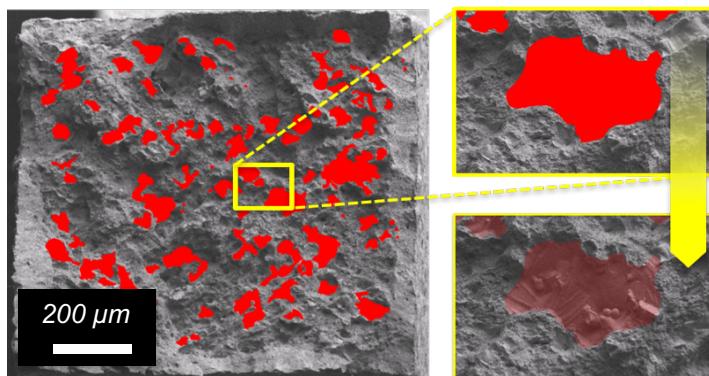


- ~6 area% of fracture surface contains lack-of-fusion defects
- Partial shear lip formation

Strain-to-Failure: 1.8%



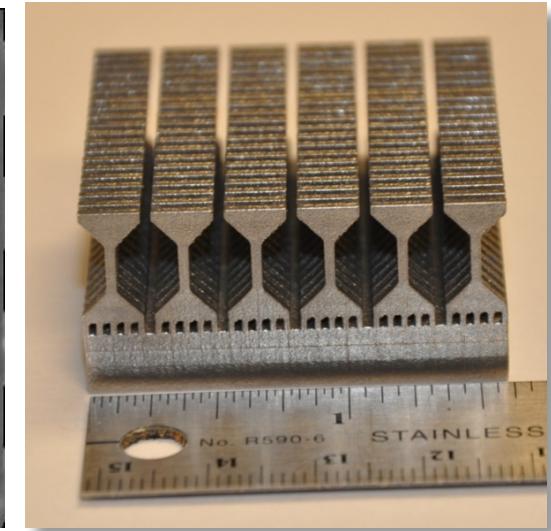
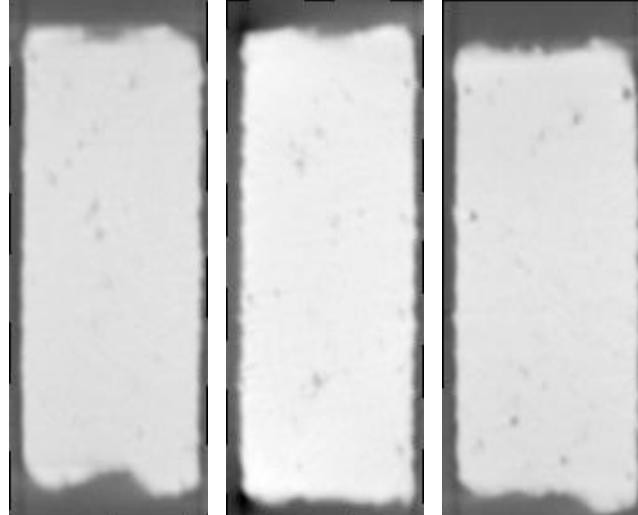
- ~22 area% of fracture surface contains lack-of-fusion defects
- Gross defects primarily all internal
- No shear lip formation—macroscopically brittle failure



μ -Computed Tomography



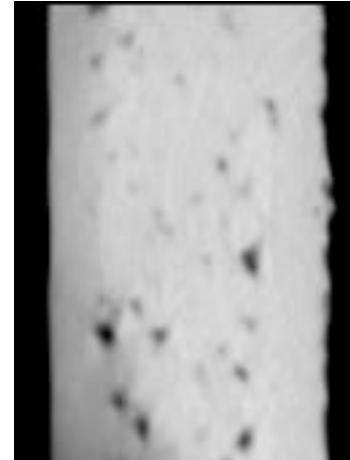
Sandia National Laboratories



17-4 PH AM Tensile Dogbones

AM sample

6 columns x 20 rows
120 tensile dog bones per build
1 mm x 1 mm tensile gage section

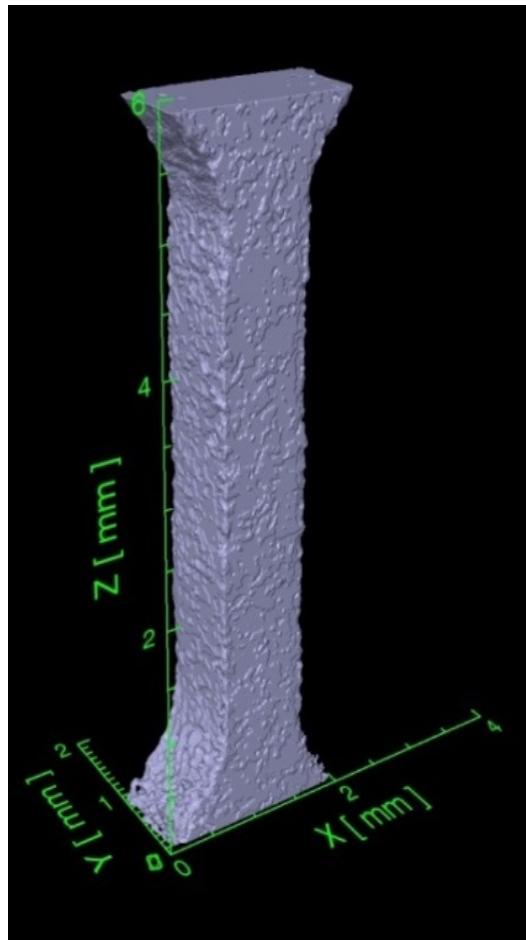


North Star Imaging, Inc. X50 XViewCT Cabinet System
YXLON Demountable Microfocus Tube (10-225kV)

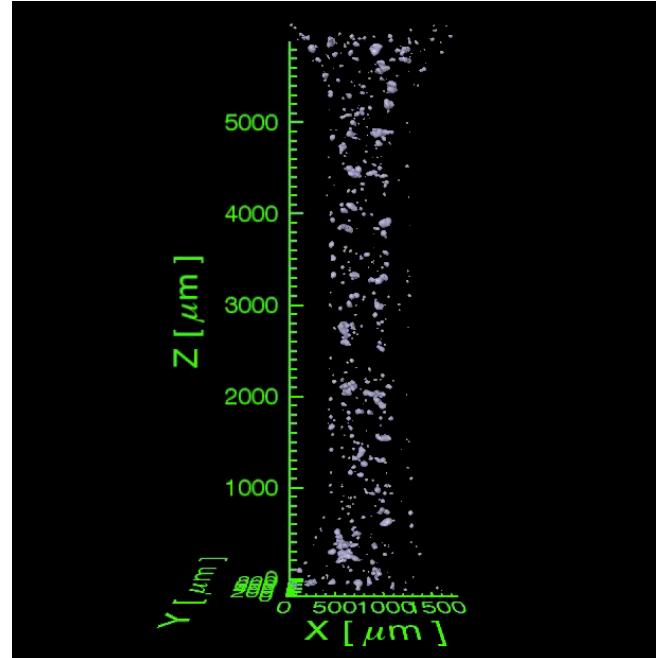
μ CT data

resolutions of 7-10 μ m per voxel edge
defect threshold > 20 μ m ESD
~ 60 MB per dataset (image stack)
7+ GB for μ CT data of entire build group

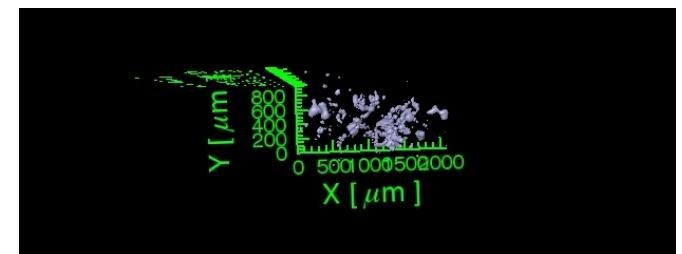
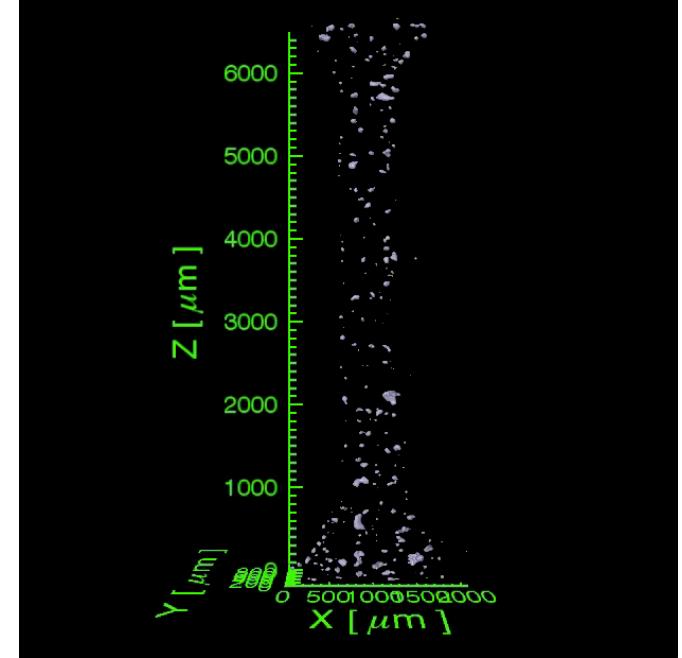
3D Reconstruction of Pore Defects



3D μ CT surface render

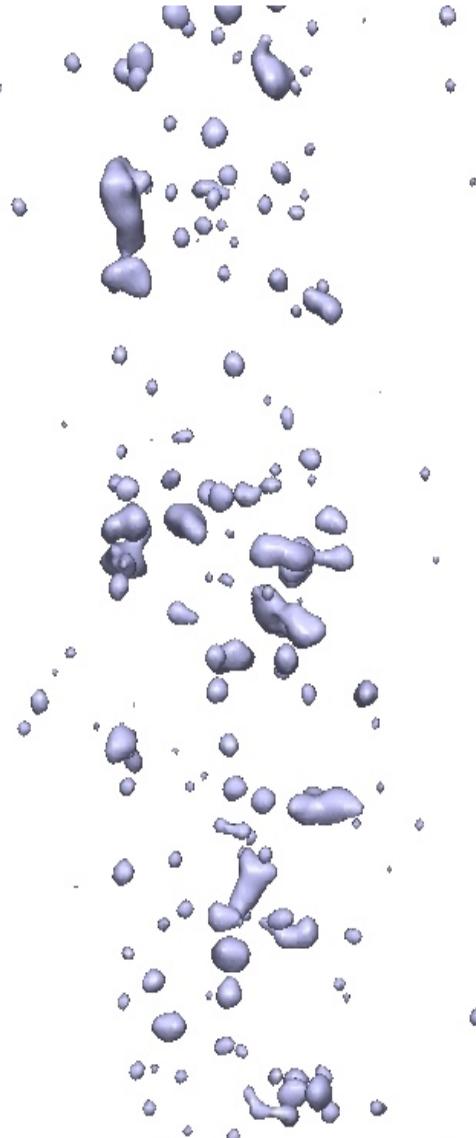


3D μ CT internal porosity



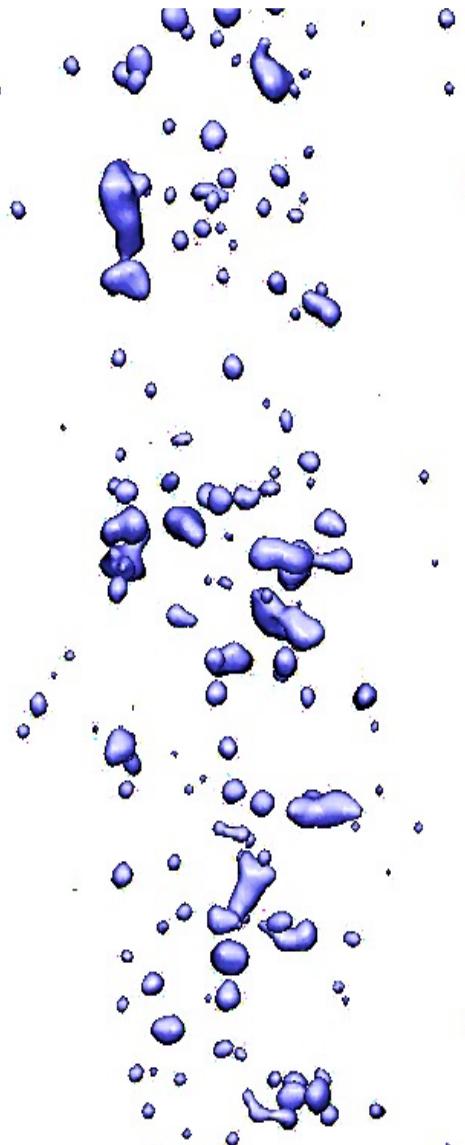
Tremendous variation in pore content from sample to sample
Pore locations reminiscent of AM laser raster pattern

Defect Quantification



How do we *best* represent the defect populations present?

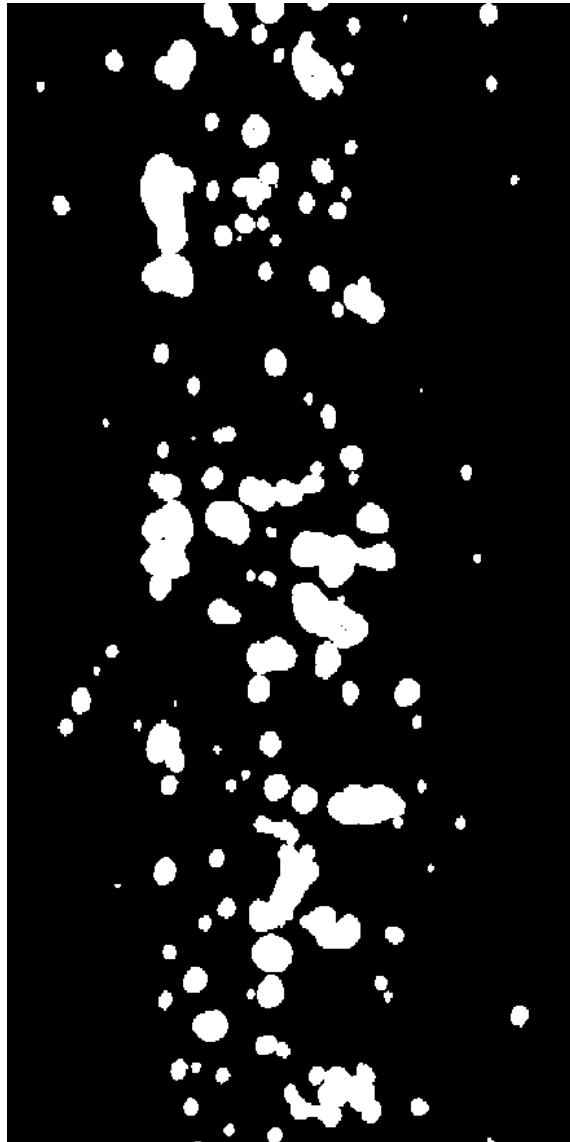
Defect Quantification



- **Total Volume of Defects (V_{tot})**

How do we *best* represent the defect populations present?

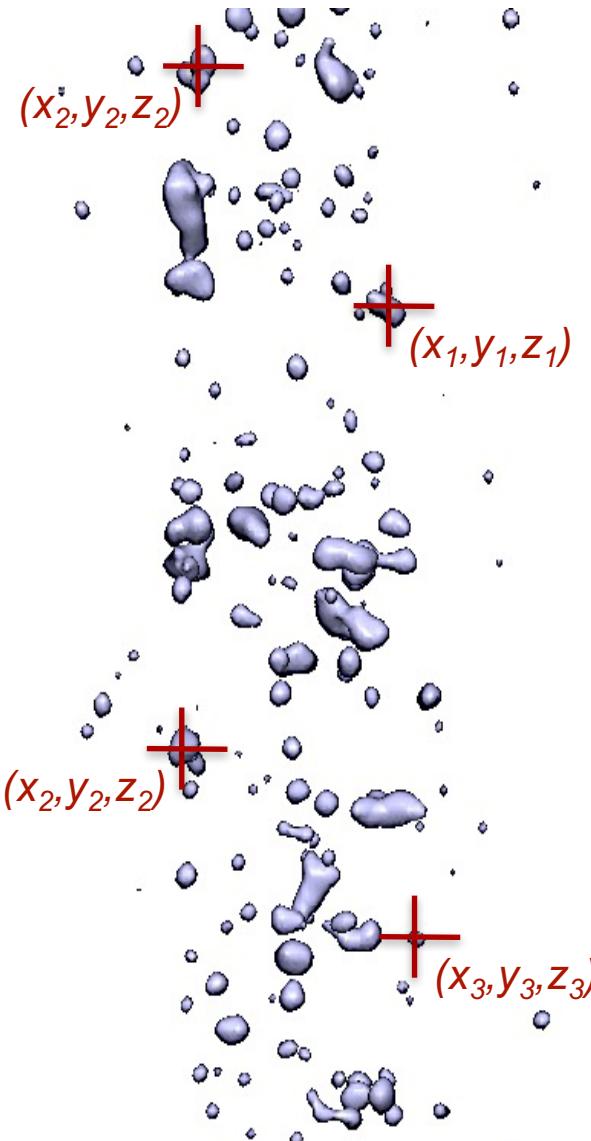
Defect Quantification



- **Total Volume of Defects (V_{tot})**
- **Pore Volume Fraction (V_{fract})**

How do we *best* represent the defect populations present?

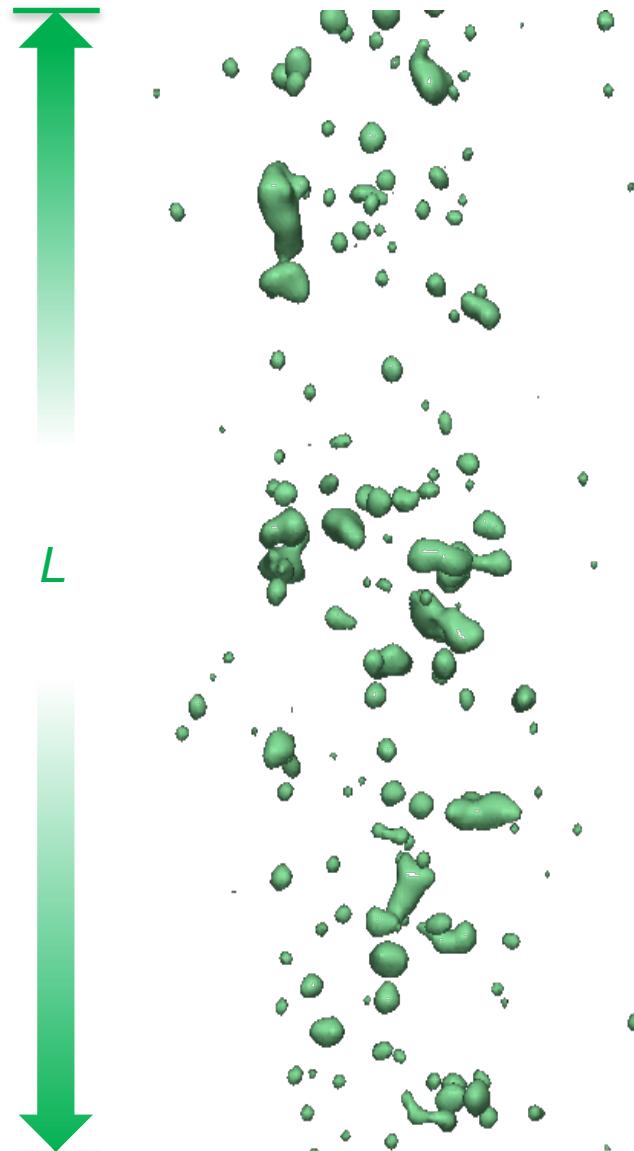
Defect Quantification



- **Total Volume of Defects (V_{tot})**
- **Pore Volume Fraction (V_{fract})**
- **Spatial Location of Pores (x, y, z)**

How do we *best* represent the defect populations present?

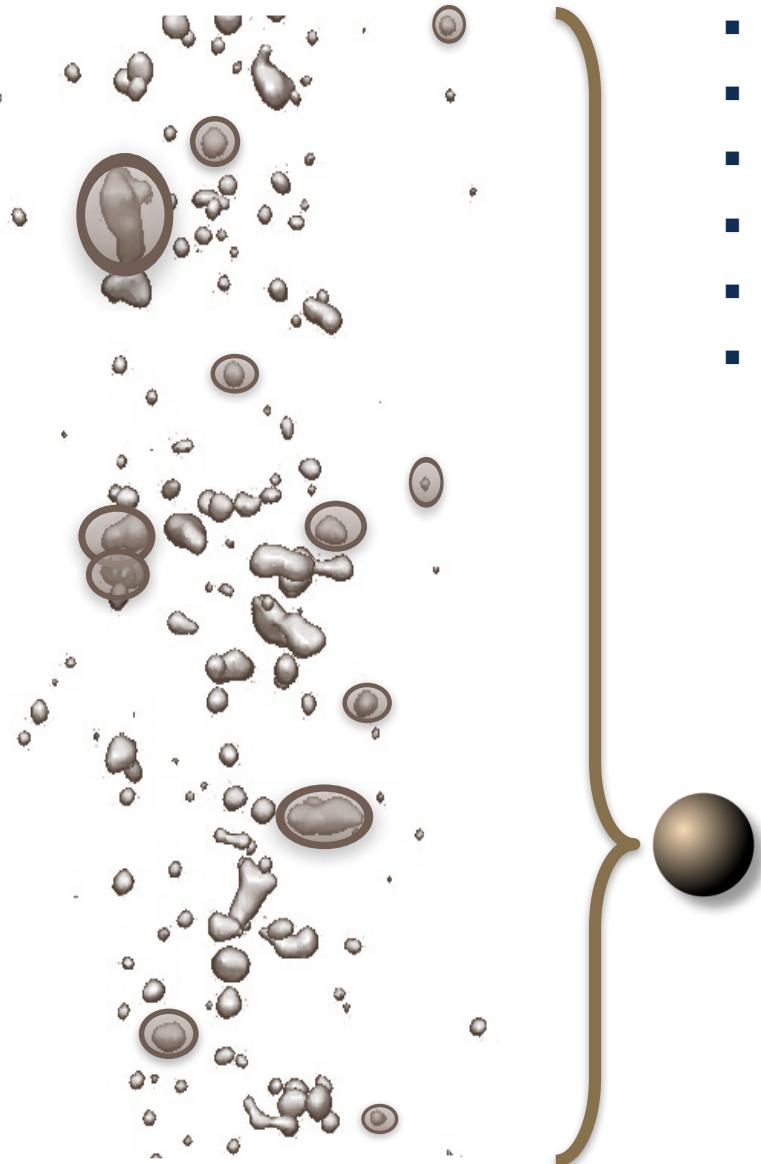
Defect Quantification



- Total Volume of Defects (V_{tot})
- Pore Volume Fraction (V_{fract})
- Spatial Location of Pores (x, y, z)
- Total Number of Defects (N)
- Total Defects/Length (N/L)

How do we *best* represent the defect populations present?

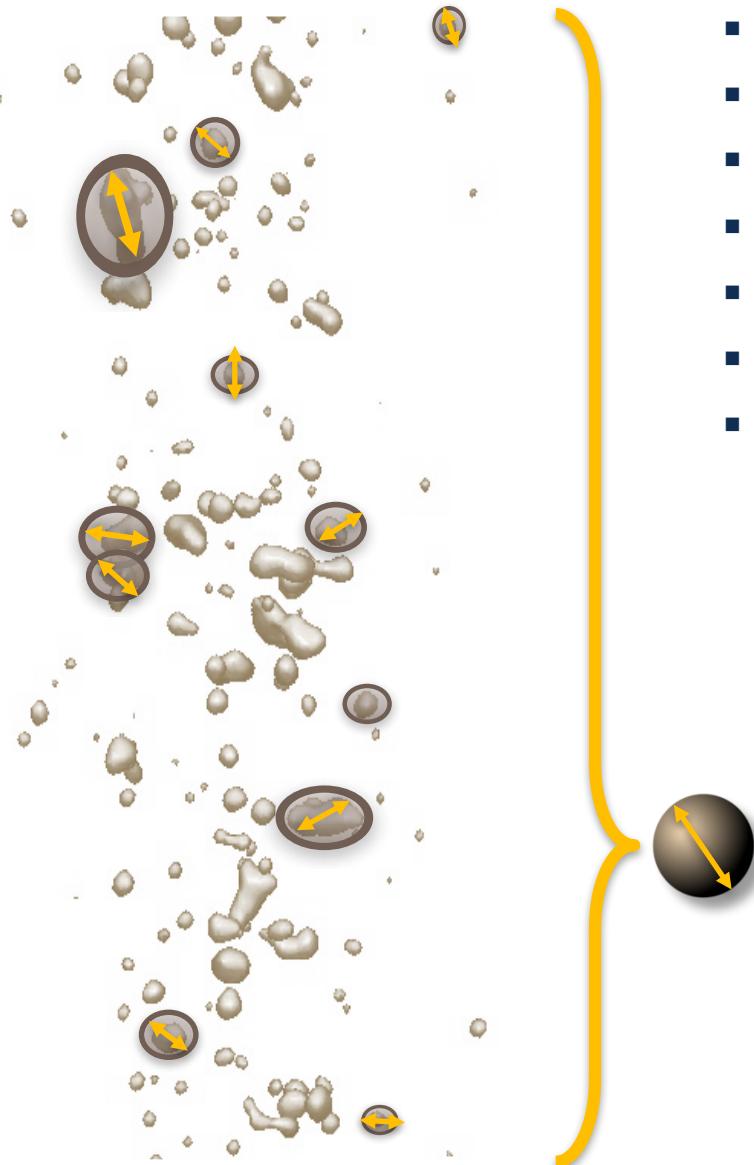
Defect Quantification



- **Total Volume of Defects (V_{tot})**
- **Pore Volume Fraction (V_{fract})**
- **Spatial Location of Pores (x, y, z)**
- **Total Number of Defects (N)**
- **Total Defects/Length (N/L)**
- **Average Defect Volume ($V_{ave.}$)***

How do we *best* represent the defect populations present?

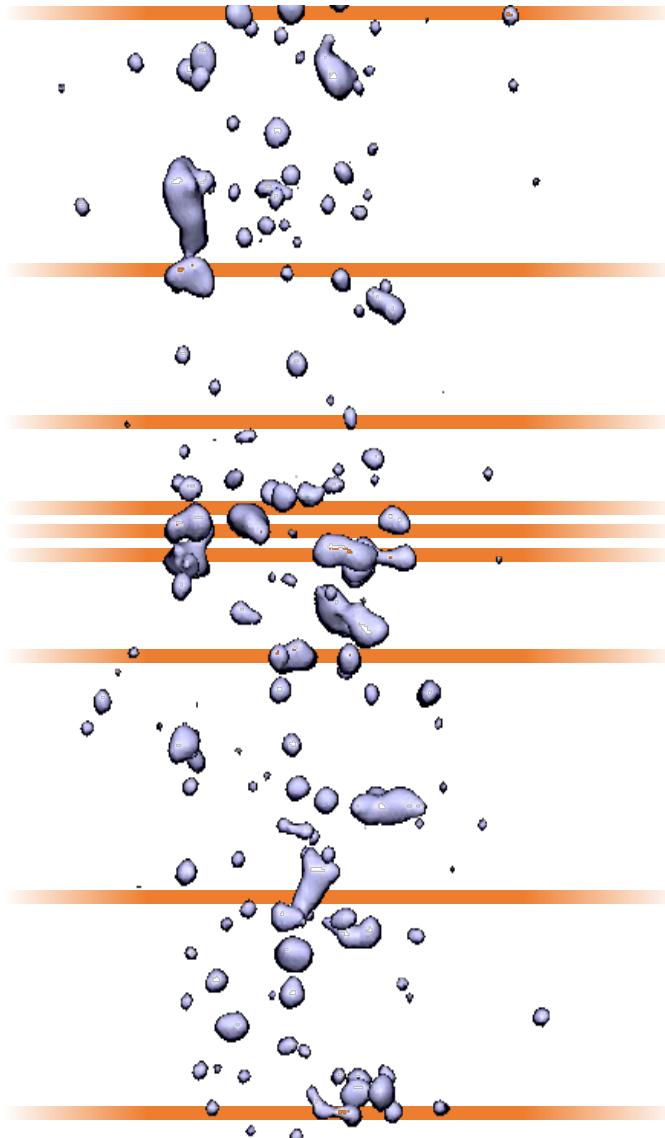
Defect Quantification



- **Total Volume of Defects (V_{tot})**
- **Pore Volume Fraction (V_{fract})**
- **Spatial Location of Pores (x, y, z)**
- **Total Number of Defects (N)**
- **Total Defects/Length (N/L)**
- **Average Defect Volume ($V_{avg.}$)***
- **Average Equivalent Spherical Diameter ($ESD_{avg.}$)***

How do we *best* represent the defect populations present?

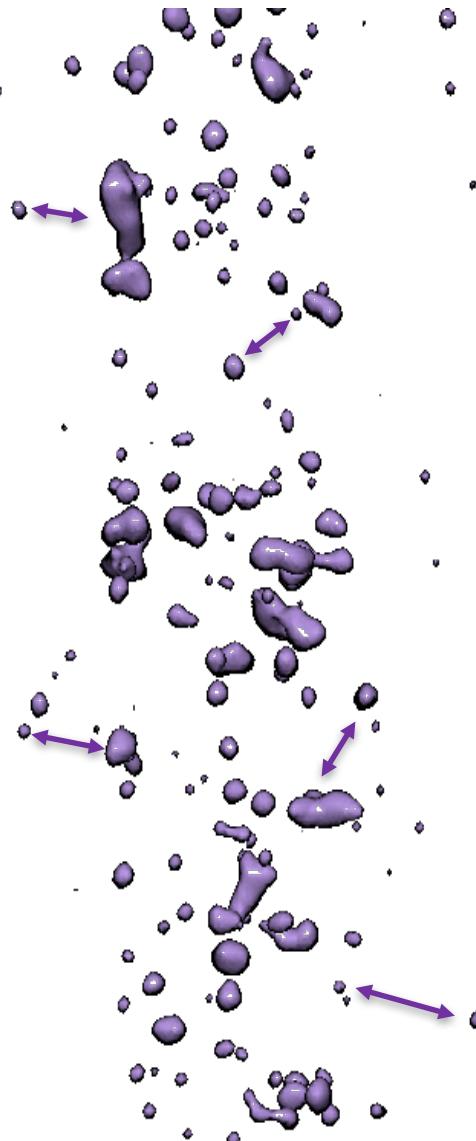
Defect Quantification



- **Total Volume of Defects (V_{tot})**
- **Pore Volume Fraction (V_{fract})**
- **Spatial Location of Pores (x, y, z)**
- **Total Number of Defects (N)**
- **Total Defects/Length (N/L)**
- **Average Defect Volume ($V_{avg.}$)***
- **Average Equivalent Spherical Diameter ($ESD_{avg.}$)***
- **Average Cross-Sectional Area ($CSA_{avg.}$)***

How do we *best* represent the defect populations present?

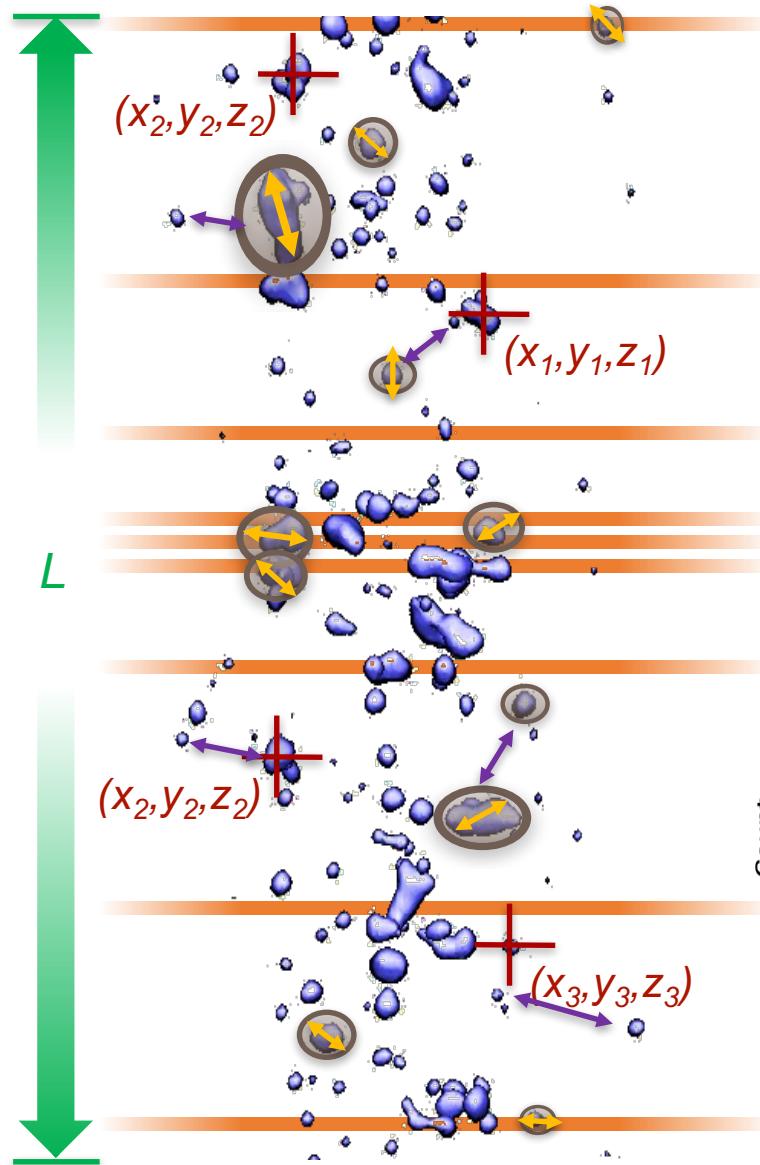
Defect Quantification



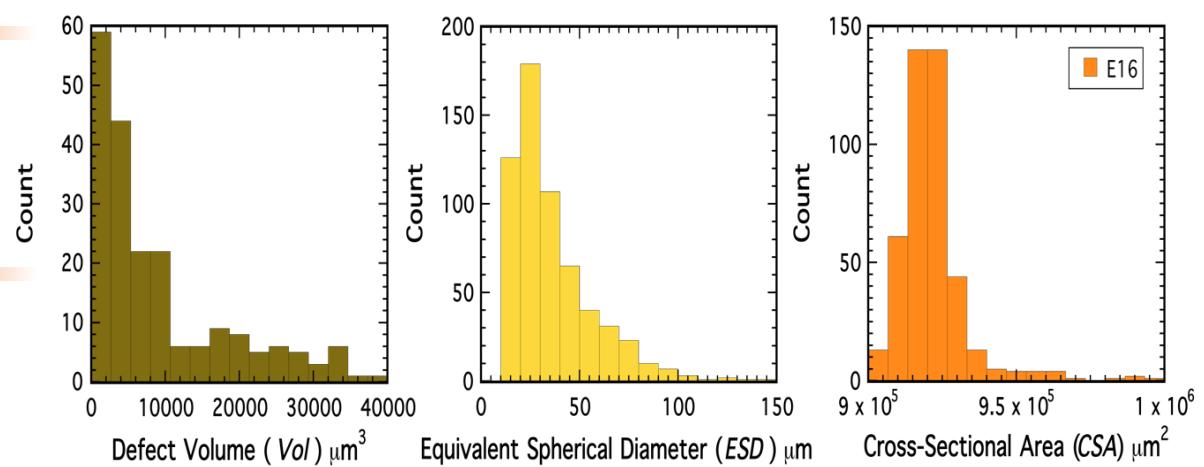
- **Total Volume of Defects (V_{tot})**
- **Pore Volume Fraction (V_{fract})**
- **Spatial Location of Pores (x, y, z)**
- **Total Number of Defects (N)**
- **Total Defects/Length (N/L)**
- **Average Defect Volume ($V_{avg.}$)***
- **Average Equivalent Spherical Diameter ($ESD_{avg.}$)***
- **Average Cross-Sectional Area ($CSA_{avg.}$)***
- **Average Nearest Neighbor Distance ($NND_{avg.}$)***

How do we *best* represent the defect populations present?

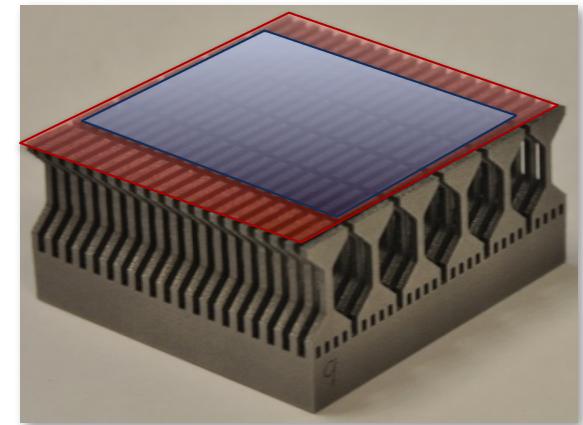
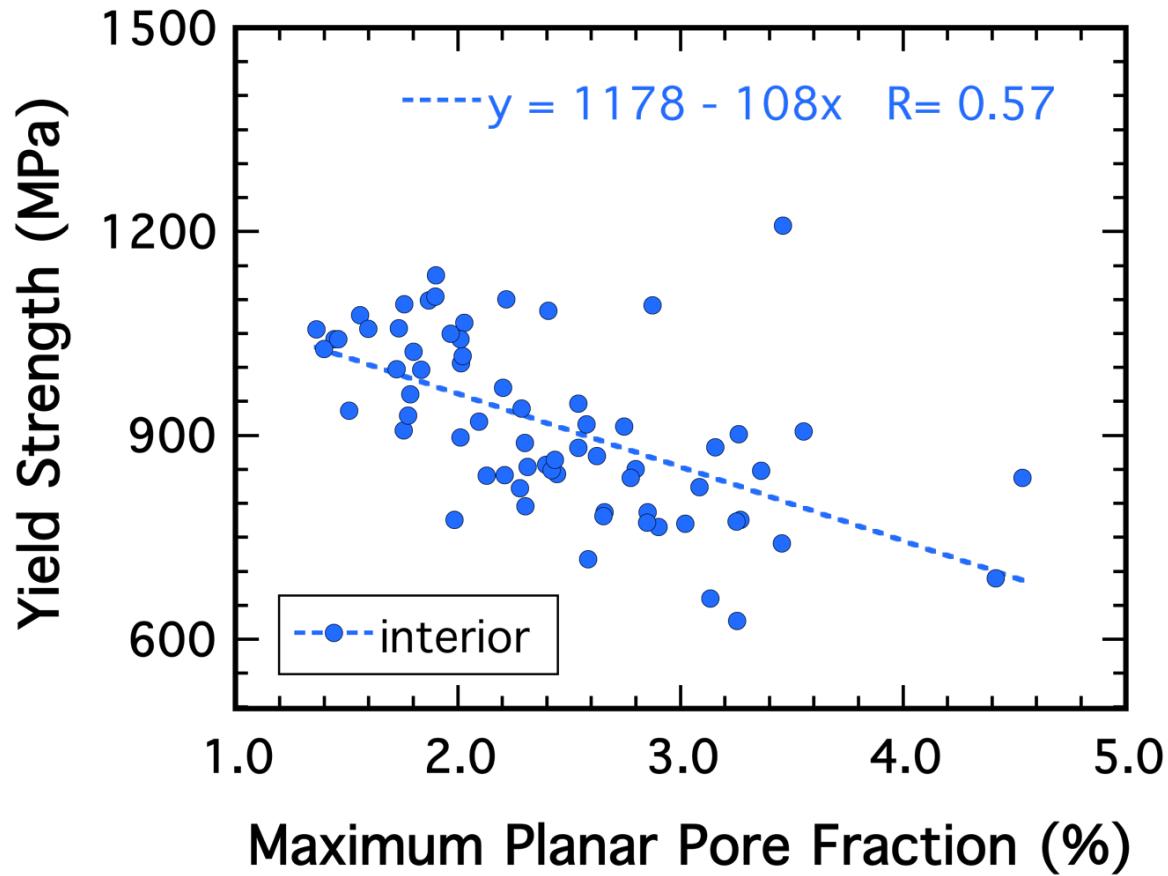
Defect Characterization



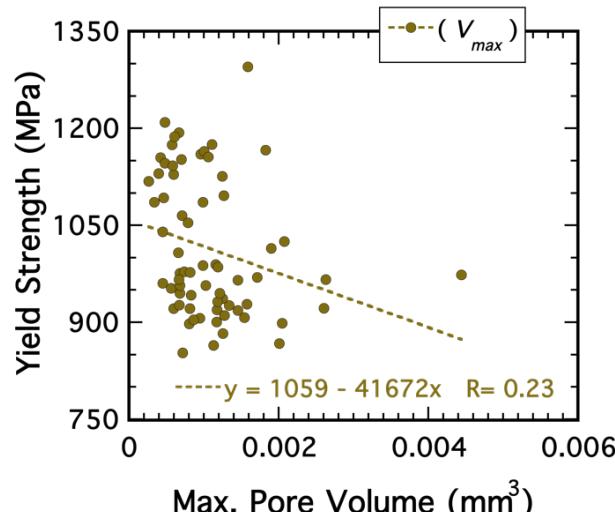
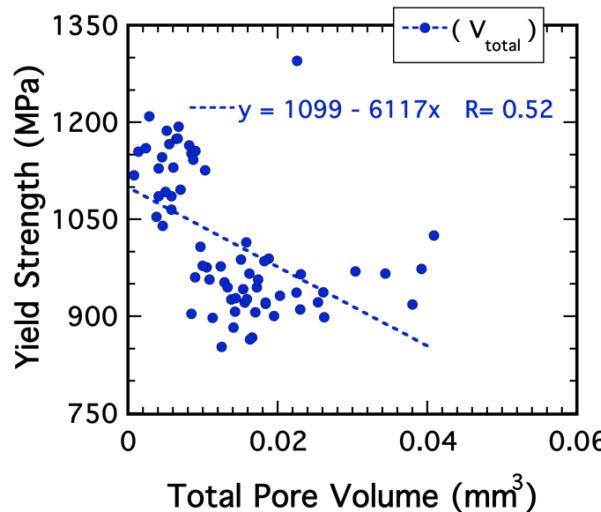
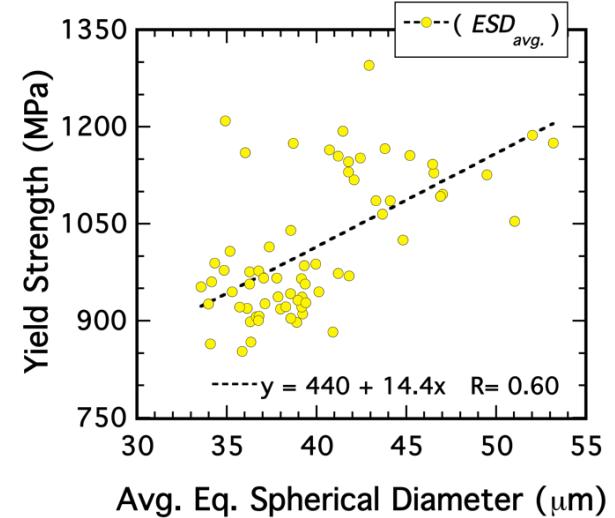
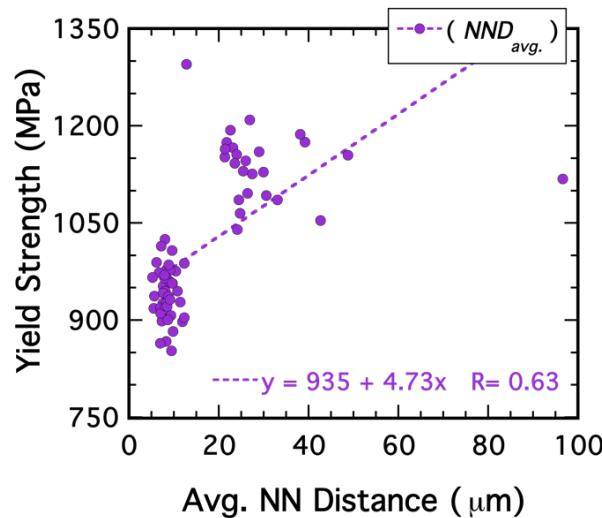
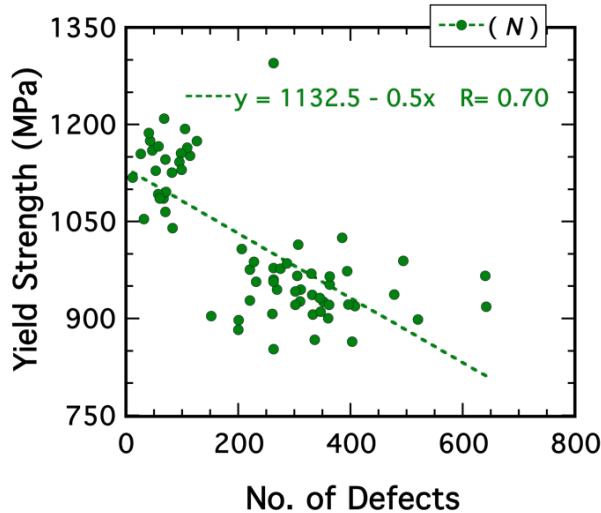
- **Total Volume of Defects (V_{tot})**
- **Pore Volume Fraction (V_{fract})**
- **Spatial Location of Pores (x, y, z)**
- **Total Number of Defects (N)**
- **Total Defects/Length (N/L)**
- **Average Defect Volume ($V_{avg.}$)***
- **Average Equivalent Spherical Diameter ($ESD_{avg.}$)***
- **Average Cross-Sectional Area ($CSA_{avg.}$)***
- **Average Nearest Neighbor Distance ($NND_{avg.}$)***



Interior Subsampling



Individual Correlations with YS



In relation to Y.S.

Measure	R value	R^2
No. of Defects	-0.705	0.50
Avg. NN Distance (mm)	0.631	0.40
Avg. ESD (mm)	0.601	0.36
Max CSA Redux (mm^2)	-0.581	0.38
Total Pore Volume (mm^3)	-0.518	0.27
Avg. Defect Vol. (mm^3)	0.500	0.25
Max CSA Redux (%)	-0.486	0.24
Maximum Pore Size	-0.257	0.07

Multivariate Regression

In relation to Y.S.

No. of Descriptors	R ²	No. of Defects (N)	Avg. Defect Volume (V _{avg.})	Avg. Equivalent Spherical Diameter (ESD _{avg.})	Total Pore Volume (V _{tot})	Maximum Pore Volume (V _{max})	Average Nearest Neighbor Distance (NND _{avg.})	Maximum Cross-Sectional Area Reduction (CSA _{redux})
1	.497	X						
1	.398						X	
2	.548	X		X				
2	.542	X	X					
3	.579	X	X					X
3	.579	X		X				X
4	.594	X	X				X	X
4	.594	X			X		X	X
5	.604	X	X		X		X	X
5	.603	X		X	X		X	X
6	.604	X	X	X	X		X	X
6	.604	X		X	X	X	X	X
7	.604	X	X	X	X	X	X	X

$$\sigma_{ys} = 1132 - 0.5(N)$$

R² ~ 0.5

$$\sigma_{ys} = 835 - 0.382 (N) + 6.74 (ESD_{avg.})$$

R² ~ 0.55

$$\sigma_{ys} = 963 - 0.431 (N) + 5.33 (ESD_{avg.}) + 3132 (V_{tot}) - 0.005 (CSA_{redux})$$

R² ~ 0.6

Conclusions

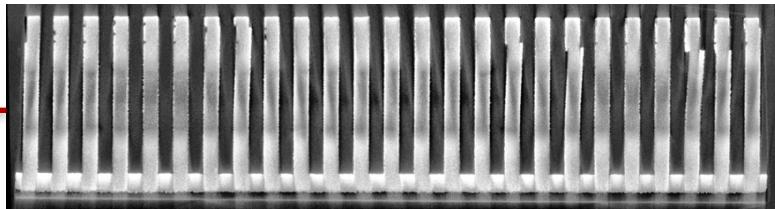
- Variation in chemical composition and surface finish between two independently vendor-produced AM lots of PH 17-4 were observed. These differences contributed to large variations in load-displacement behavior and distinctively different failure modes between both lots.
- Within one set of AM PH 17-4 stainless steel examined, total quantity of pores was the most strongly correlated pore metric relative to yield strength. Total quantity of pores exhibited a correlation coefficient (R) of 0.7 and a maximum coefficient of determination (R^2) of 0.5
- Using multivariate regression, combinatorial predictions of yield stress, as a function of multiple porosity metrics, are possible but cumulatively only account for approximately 60% of variability observed.
 - With two measures, a coefficient of determination ($\sim R^2$) of 0.55 was achieved
 - With four measures, a coefficient of determination ($\sim R^2$) of 0.60 was achieved

Questions

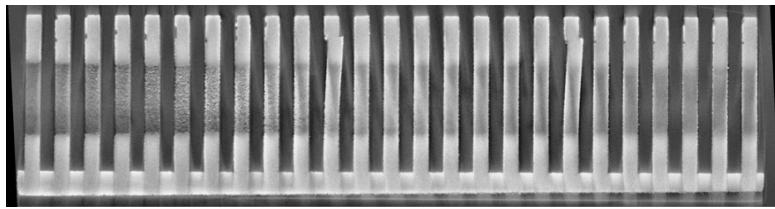
1. B. Salzbrenner, J. Rodelas, J. Madison, B. Jared, L. Swiler, Y-L. Shen, B. Boyce, "*High-Throughput Stochastic Tensile Performance of Additively Manufactured Stainless Steel*" **JOURNAL OF MATERIALS PROCESSING TECHNOLOGY**, vol. 241, (2017) pp. 1-12 doi: 10.1016/j.jmatprotec.2016.10.023

2. B. Boyce, B. Salzbrenner, J. Rodelas, L. Swiler, J. Madison, B. Jared, Y-L. Shen, "*Extreme-Value Statistics Reveal Failure-Critical Defects in Additive Manufacturing*" **ADVANCED ENGINEERING MATERIALS**, vol. 19, issue 4, (2017) pp. 1-10 doi: 10.1002/adem.201700102

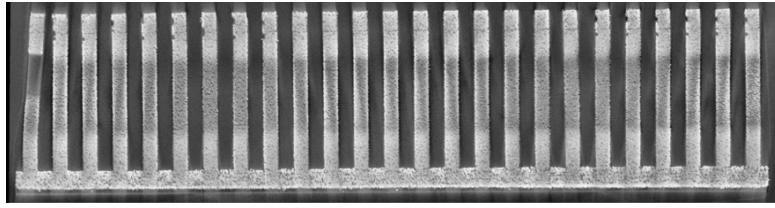
Gen 2



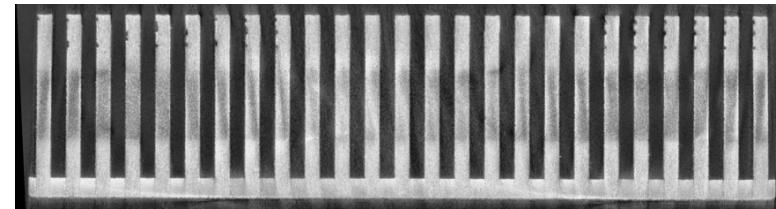
Power A



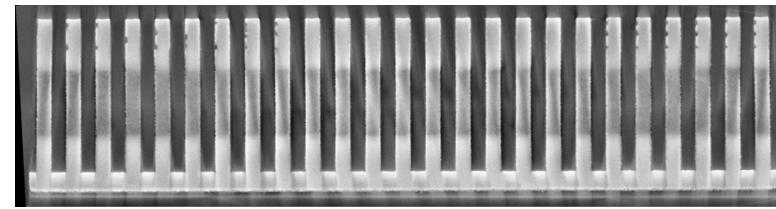
Power B



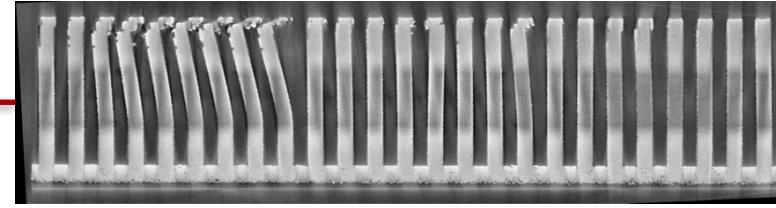
Power I



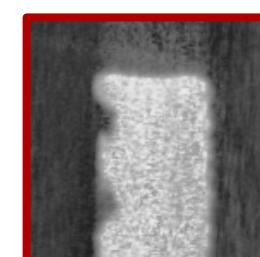
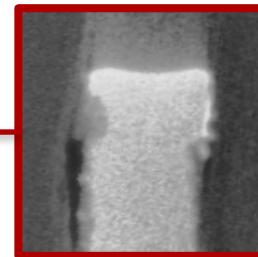
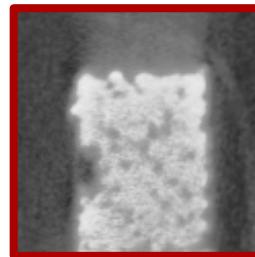
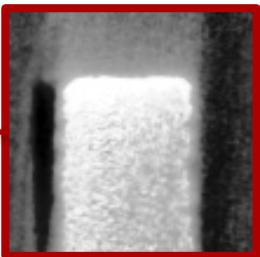
Hex Raster



Normal Raster



Mesh Raster



Load-Bearing Area

